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MOSFET - Power, Single N-Channel 80 V, 9 mΩ, 58 A

NTTYS009N08HL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	80	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain		T _C = 25°C	I _D	58	Α
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady State	T _C = 100°C		41	
Power Dissipation		T _C = 25°C	P_{D}	73	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		36	
Continuous Drain		T _A = 25°C	I _D	12	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady	T _A = 100°C		8	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	T _C = 25	°C, t _p = 10 μs	I _{DM}	590	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	60	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 26.4 A, L = 0.1 mH)			E _{AS}	35	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{ heta JC}$	2.0	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface–mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

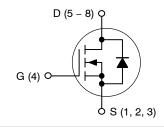


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
80 V	9 mΩ @ 10 V	58 A
	10.9 mΩ @ 4.5 V	307

N-Channel





LFPAK8 3.3x3.3 CASE 760AD

MARKING DIAGRAM

009N 08HL AWLYW

009N08HL = Specific Device Code

A = Assembly Location

WL = Wafer LotY = YearW = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-				-	-	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μA		80			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				53.4		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		V _{DS} = 80 V	T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 5)							
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A			7.1	8.6	mΩ
		V _{GS} = 4.5 V, I	V _{GS} = 4.5 V, I _D = 10 A		8.9	11	1
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 70 μA		1.2	1.6	2.0	V
Gate Threshold Voltage Temperature Coefficient	V _{GS(TH)} /T _J				-5.2		mV/°C
Forward Transconductance	9 _{FS}	V _{DS} = 5 V, I _D = 10 A			64.1		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz V _{DS} = 40 V			1402		pF
Reverse Transfer Capacitance	C _{rss}				187		pF
Output Capacitance	C _{oss}				10.5		pF
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 40 V, I _D = 10 A			2		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V, I _D = 10 A			24		1
Gate-to-Source Charge	Q_{GS}				3.5		1
Gate-to-Drain Charge	Q_{GD}				4.3		1
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t _{d(on)}				11		ns
Turn-Off Delay Time	t _{d(off)}	V _{GS} = 6 V, V _{DS}	s = 64 V,		29		1
Rise Time	t _r	$I_D = 10 \text{ A}, R_G = 6 \text{ m}\Omega$			10		1
Fall Time	t _f				9		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage V _{SD}	V_{SD}	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C		8.0	1.2	V
			T _J = 125°C		0.7		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dl/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			39		ns
Charge Time	t _a				20		7
Discharge Time	t _b				20		7
Reverse Recovery Charge	Q_{RR}				27		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

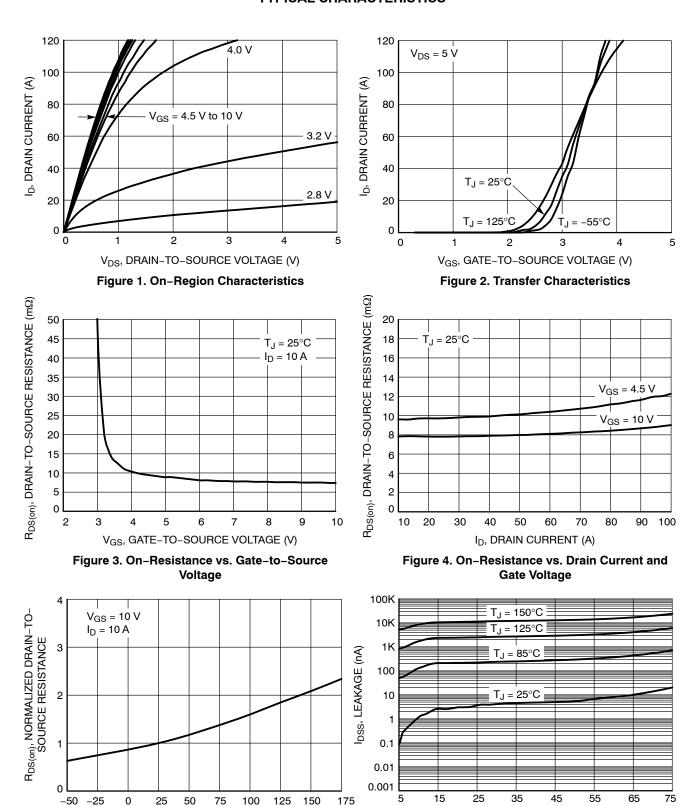


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

TYPICAL CHARACTERISTICS

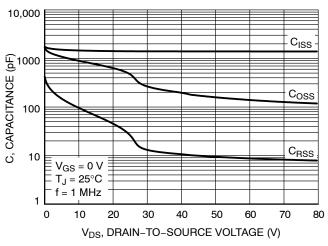


Figure 7. Capacitance Variation

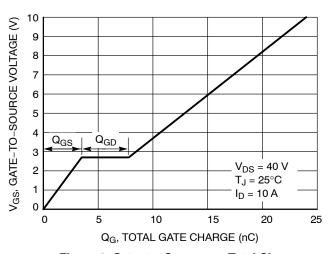


Figure 8. Gate-to-Source vs. Total Charge

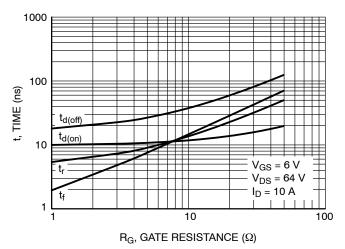


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

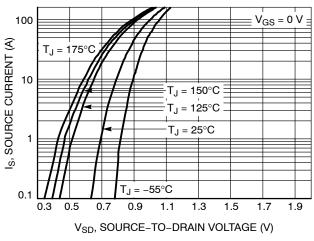


Figure 10. Diode Forward Voltage vs. Current

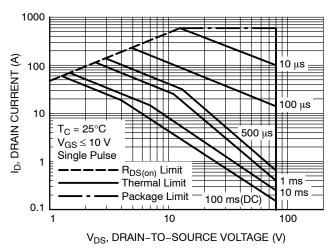


Figure 11. Maximum Rated Forward Biased Safe Operating Area

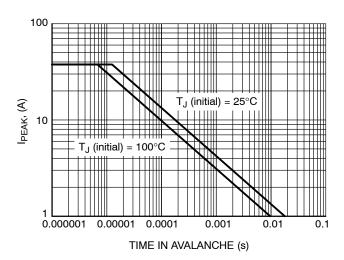


Figure 12. Maximum Drain Curent vs. Time in Avalanche

TYPICAL CHARACTERISTICS

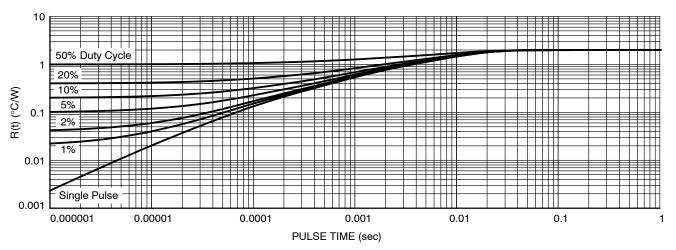


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

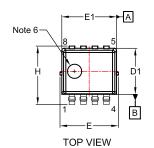
Device	Marking	Package	Shipping [†]
NTTYS009N08HLTWG	009N 08HL	LFPAK8 (Pb-Free)	3000 / Tape & Reel

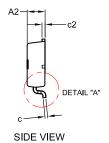
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

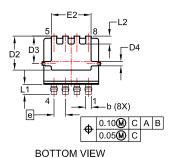
PACKAGE DIMENSIONS

LFPAK8 3.3x3.3, 0.65P

CASE 760AD ISSUE E

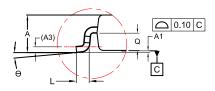




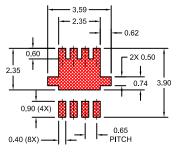


DIM MIN. MAX. NOM. 0.95 1.05 1.15 Α 0.10 Α1 0.00 0.05 1.05 0.95 A2 1.00 0.15 REF АЗ 0.27 0.32 0.37 b 0.12 0.17 0.22 С 0.12 0.17 0.22 c2 D1 2.50 2.60 2.70 D2 1.82 1.92 2.02 D3 1.46 1.56 1.66 0.20 0.25 0.30 D4 F 3.20 3.30 3.40 E1 3.00 3.10 3.20 E2 2.15 2.25 2.35 0.65 BSC е Н 3.20 3.30 3.40 L 0.25 0.37 0.50 L1 0.48 0.58 0.68 L2 0.35 0.45 0.55 Q 0.45 0.50 0.55 θ 0° 4° 8°

MILLIMETERS



DETAIL 'A' SCALE: 2:1



LAND PATTERN RECOMMENDATION

'FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS OR BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 6. OPTIONAL MOLD FEATURE.

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